# **Power MOSFET**

# 30 V, 7.0 A, Single N-Channel, TSOP-6

#### **Features**

- Low R<sub>DS(on)</sub>
- Low Gate Charge
- Pb-Free Package is Available

### **Applications**

- Load Switch
- Notebook PC
- Desktop PC

## **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Rating			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	30	V
Gate-to-Source Voltage			$V_{GS}$	±20	V
Continuous Drain	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	5.0	Α
Current (Note 1)	State	T <sub>A</sub> = 85°C		3.6	
	t ≤ 10 s	T <sub>A</sub> = 25°C		7.0	
Power Dissipation (Note 1)	Steady T <sub>A</sub> = 25°C State		P <sub>D</sub>	1.0	W
	t ≤ 10 s			2.0	
Continuous Drain	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	3.5	Α
Current (Note 2)	State	T <sub>A</sub> = 85°C		2.5	
Power Dissipation (Note 2)		T <sub>A</sub> = 25°C	P <sub>D</sub>	0.5	W
Pulsed Drain Current	t <sub>p</sub> =	10 μs	I <sub>DM</sub>	21	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	–55 to 150	°C
Source Current (Body Diode)			I <sub>S</sub>	2.0	Α
Single Pulse Drain-to–Source Avalanche Energy (V <sub>DD</sub> = 30 V, I <sub>L</sub> = 10.4 A, V <sub>GS</sub> = 10 V, L = 1.0 mH, R <sub>G</sub> = 25 $\Omega$ )			EAS	54	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

### THERMAL RESISTANCE RATINGS

Rating	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	125	°C/W
Junction-to-Ambient – t ≤ 10 s (Note 1)	$R_{\theta JA}$	62.5	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	248	

- Surface-mounted on FR4 board using 1 inch sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
- Surface-mounted on FR4 board using the minimum recommended pad size (Cu area = 0.0773 in sq).

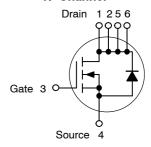


# ON Semiconductor®

## http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> TYP	I <sub>D</sub> MAX
30 V	21.5 mΩ @ 10 V	7.0 A
	30 V 30 mΩ @ 4.5 V	

#### N-Channel





## TSOP-6 CASE 318G STYLE 1



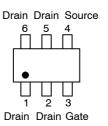
**MARKING** 

S4 = Device Code M = Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

## **PIN ASSIGNMENT**



## **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTGS4141NT1	TSOP-6	3000/Tape & Reel
NTGS4141NT1G	TSOP-6 (Pb-Free)	3000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS			•				
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				18.4		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 24 V	T <sub>J</sub> = 25°C			1.0	μΑ
			T <sub>J</sub> = 125°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>0</sub>	<sub>GS</sub> = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{I}$	<sub>D</sub> = 250 μA	1.0		3.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				5.7		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V,	I <sub>D</sub> = 7.0 A		21.5	25	mΩ
		V <sub>GS</sub> = 4.5 V,	I <sub>D</sub> = 6.0 A		30	35	
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 10 V,	I <sub>D</sub> = 7.0 A		30		S
CHARGES, CAPACITANCES AND GATE RE	SISTANCE						
Input Capacitance	C <sub>ISS</sub>				560		pF
Output Capacitance	C <sub>OSS</sub>		$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,} $ $V_{DS} = 24 \text{ V}$		115		1
Reverse Transfer Capacitance	C <sub>RSS</sub>	ν <sub>DS</sub> – Ζ+ ν			75		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V, I <sub>D</sub> = 7.0 A			12		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				0.85		-
Gate-to-Source Charge	$Q_{GS}$				1.9		
Gate-to-Drain Charge	$Q_{GD}$				3.0		
Total Gate Charge	Q <sub>G(TOT)</sub>				6.0		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, \	/ <sub>DS</sub> = 15 V,		0.8		
Gate-to-Source Charge	$Q_{GS}$	I <sub>D</sub> = 7.0 A			1.85		
Gate-to-Drain Charge	$Q_{GD}$				3.0		
Gate Resistance	$R_{G}$				2.8		Ω
SWITCHING CHARACTERISTICS (Note 4)							
Turn-On Delay Time	t <sub>d(ON)</sub>				6.0		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V	<sub>'DS</sub> = 24 V,		15		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 7.0 \text{ A}, R_G = 3.0 \Omega$			18		
Fall Time	t <sub>f</sub>				4.0		<u></u>
DRAIN - SOURCE DIODE CHARACTERIST	ics						
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 2.0 A	T <sub>J</sub> = 25°C		0.78	1.0	٧
			T <sub>J</sub> = 125°C		0.63		]
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V}$ $dI_{S}/dt = 100 \text{ A/}\mu\text{s}, I_{S} = 2.0 \text{ A}$			15		ns
Charge Time	t <sub>a</sub>				9.0		1
Discharge Time	t <sub>b</sub>				6.0		1
Reverse Recovery Charge	Q <sub>RR</sub>				8.0		nC

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

## TYPICAL PERFORMANCE CURVES

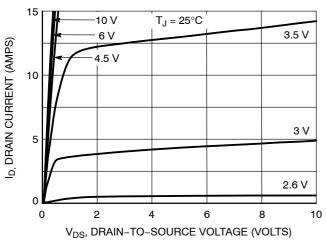


Figure 1. On-Region Characteristics

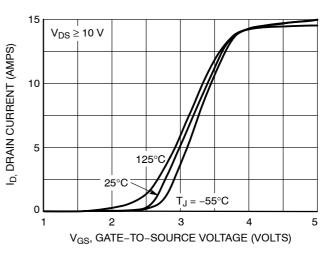


Figure 2. Transfer Characteristics

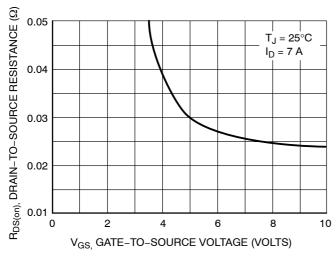


Figure 3. On-Resistance vs. Gate-to-Source Voltage

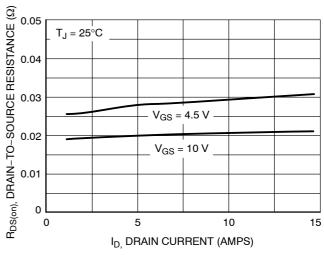


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

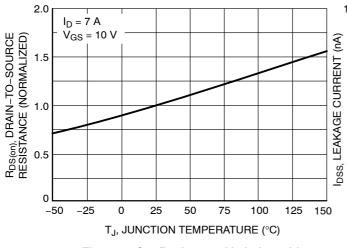


Figure 5. On–Resistance Variation with Temperature

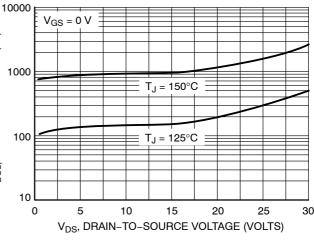
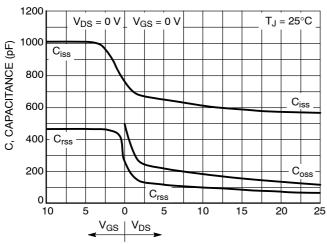


Figure 6. Drain-to-Source Leakage Current vs. Voltage

## TYPICAL PERFORMANCE CURVES

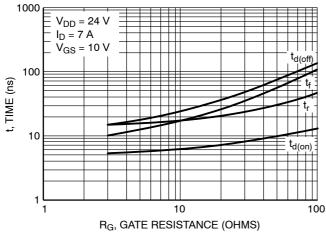


VGS GATE-TO-SOURCE VOLTAGE (V) QΤ 8  $V_{GS}$ 6  $\overline{\phantom{a}}$ Q<sub>GS</sub> $\overline{\phantom{a}}$  $Q_{GD}$  $I_D = 7 A$ 2 V<sub>DD</sub> = 15 V T<sub>J</sub> = 25°C 0 0 2 4 6 10 12 Q<sub>G</sub>, TOTAL GATE CHARGE (nC)

GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

Figure 7. Capacitance Variation



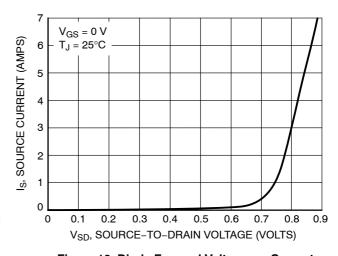
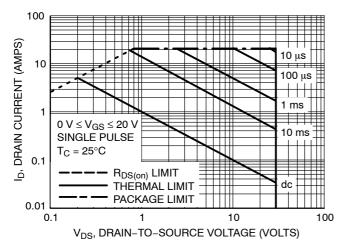


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current



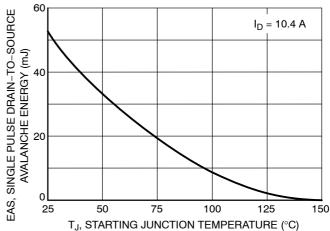


Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

## **TYPICAL PERFORMANCE CURVES**

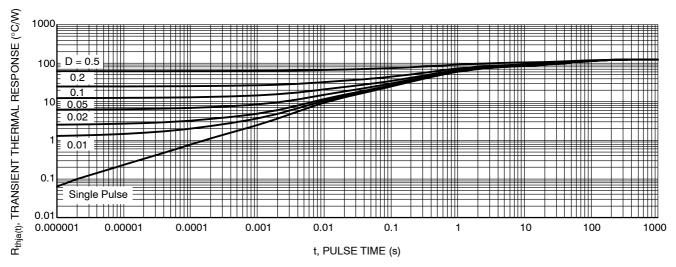
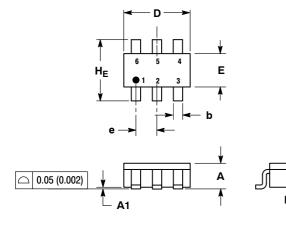


Figure 13. Thermal Response

### PACKAGE DIMENSIONS

## TSOP-6 CASE 318G-02 **ISSUE T**





- TIDIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETER. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.

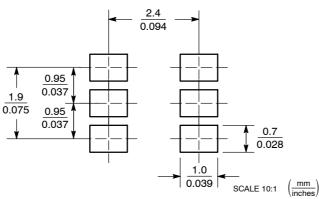
  4. DIMENSIONS A AND B DO NOT INCLUDE MOLD FLASH.
- PROTRUSIONS, OR GATE BURRS.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.90	1.00	1.10	0.035	0.039	0.043
A1	0.01	0.06	0.10	0.001	0.002	0.004
b	0.25	0.38	0.50	0.010	0.014	0.020
С	0.10	0.18	0.26	0.004	0.007	0.010
D	2.90	3.00	3.10	0.114	0.118	0.122
E	1.30	1.50	1.70	0.051	0.059	0.067
е	0.85	0.95	1.05	0.034	0.037	0.041
L	0.20	0.40	0.60	0.008	0.016	0.024
HE	2.50	2.75	3.00	0.099	0.108	0.118
θ	0°	_	10°	0°	_	10°

- STYLE 1: PIN 1. DRAIN
  - 2. DRAIN 3. GATE

  - 4. SOURCE
  - 5 DRAIN
  - DRAIN

#### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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